Docket No.

192520US2

IN RE APPLICATION OF: Hayashi OTSUKI, et al.

SERIAL NO: 09/594,479 FILED:

June 14, 2000

FOR:

PARTICLE-MEASURING SYSTEM AND PARTICLE-MEASURING METHOD TC 2800 MAIL ROOM

ASSISTANT COMMISSIONER FOR PATENTS WASHINGTON, D.C. 20231

SIR:

Transmitted herewith is an amendment in the above-identified application.

- No additional fee is required
- Small entity status of this application under 37 C.F.R. §1.9 and §1.27 is claimed.
- Additional documents filed herewith:

Marked-up Copy of Amendment

FEB 0 4 2002

Request for Extension of Time (1 Month)

The Fee has been calculated as shown below:

CLAIMS	CLAIMS REMAINING		HIGHEST NUMBER PREVIOUSLY PAID	NO. EXTRA CLAIMS	RATE	CALCULATIONS
TOTAL	20	MINUS	20	0	× \$18 =	\$0.00
INDEPENDENT	7	MINUS	5	2	× \$84 =	\$168.00
		□ MULTIPLE DEPENDENT CLAIMS + \$280 =				\$0.00
			TOTAL OF A	BOVE CALCU	JLATIONS	\$168.00
	•.	☐ Reduction by 50% for filing by Small Entity				\$0.00
,		□ Recore	dation of Assignment		+ \$40 =	\$0.00
					TOTAL	\$168.00

- A check in the amount of \$278.00 is attached.
- Please charge any additional Fees for the papers being filed herewith and for which no check is enclosed herewith, or credit any overpayment to deposit Account No. 15-0030. A duplicate copy of this sheet is enclosed.
- If these papers are not considered timely filed by the Patent and Trademark Office, then a petition is hereby made under 37 C.F.R. §1.136, and any additional fees required under 37 C.F.R. §1.136 for any necessary extension of time may be charged to Deposit Account No. 15-0030. A duplicate copy of this sheet is enclosed.

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Tel. (703) 413-3000 Fax. (703) 413-2220 (OSMMN 10/00)

OBLON, SPLVAK, McCLELLAND, MAIER & NEUSTADT, P.C.

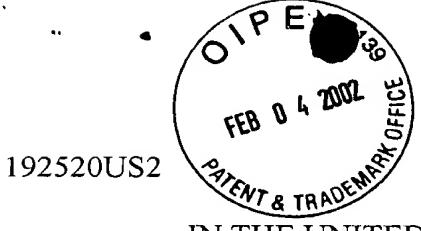
Gregory J. Maier

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Robert T. Pous

Registration No. 29,099

GJM:RTP:KDP:brf I:\atty\kdp\192520US2\Amend Cvr.wpd



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IN THE UNITED STATES PATENT & TRADEMARKO OFFICE?

IN RE APPLICATION OF:

TC 2800 MAIL ROOM

51,

Hayashi OTSUKI, et al.

: GROUP ART UNIT: 2877

SERIAL NO: 09/594,479

FILED: JUNE 14, 2000

: EXAMINER: PUNNOOSE, R.

FOR: PARTICLE-MEASURING

SYSTEM AND PARTICLE-MEASURING METHOD

AMENDMENT

ASSISTANT COMMISSIONER FOR PATENTS WASHINGTON, D.C. 20231

-SIR:

In response to the Official Action dated October 3, 2001, reconsideration of the above-identified application is respectfully requested in view of the following amendments and remarks.

IN THE SPECIFICATION

Please amend the specification as shown in the marked-up copy attached to read as follows:

Please replace the paragraph beginning on page 5, line 20, with the following text:

 $\mathcal{O}_{/}$

Further, the exhaust gas is swirled within the exhaust pipe near the discharge side of the vacuum pump 22. Therefore, the same particles cross the laser beams repeatedly, and they are counted a plurality of times.

Please replace the paragraph beginning on page 6, line 16, with the following text:

02/08/2002 HABDI1

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